PATENT 8003-1041

IN THE U.S. PATENT AND TRADEMARK OFFICE 30 MAY 2005

In re application of

Hiroki NAKAMARU et al.

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed May 30, 2006

Examiner

BLACK COLORED STEEL SHEET

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

May 30, 2006

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

... II. COPIES

Copies	of	the U	.s.	patents	or pub	olications	are	not	submitted
since t	the	USPTO	nas	waived	their	submission	n for	app	olications
filed a	ıfter	r June	30,	2003.					

- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

Ä									
III.	CONC.	SE EX	relanation of the relevance least one box) APZUREC OPCT/PTO 30 MAY 2006						
	a.		DOCUMENTS IN THE ENGLISH LANGUAGE						
			The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy.						
	b.		DOCUMENTS NOT IN THE ENGLISH LANGUAGE						
			A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:						
	c.	\boxtimes	FOREIGN SEARCH REPORT OR ACTION						
			An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).						
	d.		OTHER						
The following additional information is provided for the Examiner's consideration.									
<u>FEES</u>									
This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.									
If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.									
Respectfully submitted,									
			Benock Castel						
			Benoit Castel, Reg. No. 35,041 745 South 23 rd Street Arlington, VA 22202 Telephone (703) 521-2297 Telefax (703) 685-0573 (703) 979-4709						
BC/i	ia								
Encl	losure	es:							
			<pre>Documents</pre>						
			Other:						

EXAMINER:

AP20 Rec'd PCT/PTO 30 MAY 2006 et 1 of 1

Attorney Docket No.: 8003-1041 INFORMATION DISCLOSURE CITATION IN AN APPLICATION Applicant: Hiroki NAKAMARU et al. (Use several sheets if necessary) Filing Date: Group Art Unit: May 30, 2006 **U.S. PATENT DOCUMENTS** Subclass Filing date Class Date Name Examiner **Document Number** Initial (if appropriate) FOREIGN PATENT DOCUMENTS Subclass Translation Class Examiner **Document Number** Date Country Initial Yes No JP 2001-164377 6/19/2001 **JAPAN** JAPAN JP 2003-221686 8/8/2003 2/21/2003 JAPAN JP 2003-49281 JP 10-231442 9/2/1998 **JAPAN** OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

DATE CONSIDERED

^{*} English language abstract provided for the Examiner's convenience